



# CY74FCT16823T CY74FCT162823T

## 18-Bit Register

### Features

- Low power, pin compatible replacement for ABT functions
- FCT-C speed at 6.0 ns
- Power-off disable outputs permits live insertion
- Edge-rate control circuitry for significantly improved noise characteristics
- Typical output skew < 250 ps
- ESD > 2000V
- TSSOP (19.6-mil pitch) and SSOP (25-mil pitch) packages
- Extended commercial range of  $-40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$
- $V_{CC} = 5V \pm 10\%$

### CY74FCT16823T Features:

- 64 mA sink current (Com'l), 32 mA source current (Com'l)
- Typical  $V_{OLP}$  (ground bounce) < 1.0V at  $V_{CC} = 5V$ ,  $T_A = 25^{\circ}\text{C}$

### CY74FCT162823T Features:

- Balanced output drivers: 24 mA
- Reduced system switching noise
- Typical  $V_{OLP}$  (ground bounce) < 0.6V at  $V_{CC} = 5V$ ,  $T_A = 25^{\circ}\text{C}$

### Functional Description

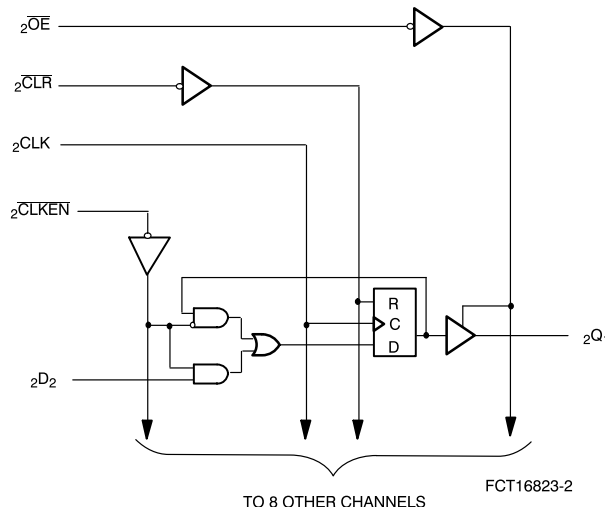
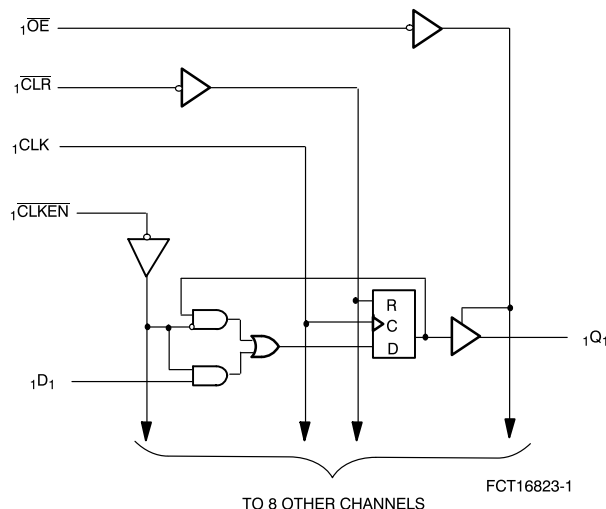
The CY74FCT16823T and the CY74FCT162823T 18-bit bus interface register are designed for use in high-speed, low-power systems needing wide

registers and parity. 18-bit operation is achieved by connecting the control lines of the two 9-bit registers. Flow-through pinout and small shrink packaging aids in simplifying board layout. The outputs are designed with a power-off disable feature to allow live insertion of boards.

The CY74FCT16823T is ideally suited for driving high-capacitance loads and low-impedance backplanes.

The CY74FCT162823T has 24-mA balanced output drivers with current limiting resistors in the outputs. This reduces the need for external terminating resistors and provides for minimal undershoot and reduced ground bounce. The CY74FCT162823T is ideal for driving transmission lines.

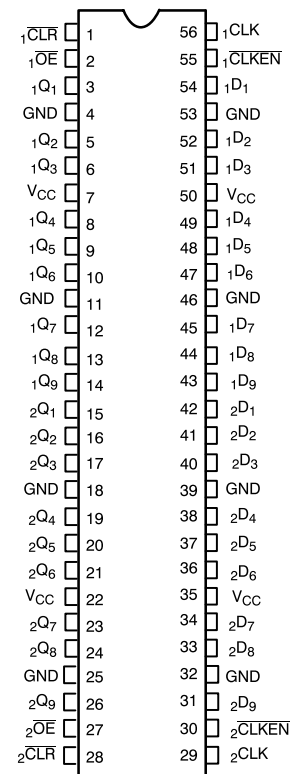
### Logic Block Diagrams



### Pin Configuration

#### SSOP/TSSOP

#### Top View



FCT16823-3



## Pin Description

| Name                      | Description                            |
|---------------------------|--|
| D                         | Data Inputs                            |
| CLK                       | Clock Inputs                           |
| $\overline{\text{CLKEN}}$ | Clock Enable Inputs (Active LOW)       |
| $\overline{\text{CLR}}$   | Asynchronous Clear Inputs (Active LOW) |
| $\overline{\text{OE}}$    | Output Enable Inputs (Active LOW)      |
| Q                         | Three-State Outputs                    |

## Maximum Ratings<sup>[3, 4]</sup>

(Above which the useful life may be impaired. For user guidelines, not tested.)

Storage Temperature . . . . . Com'l  $-55^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$   
Ambient Temperature with  
Power Applied . . . . . Com'l  $-55^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$   
DC Input Voltage . . . . .  $-0.5\text{V}$  to  $+7.0\text{V}$   
DC Output Voltage . . . . .  $-0.5\text{V}$  to  $+7.0\text{V}$   
DC Output Current  
(Maximum Sink Current/Pin) . . . . .  $-60$  to  $+120$  mA

### Notes:

1. H = HIGH Voltage Level.  
L = LOW Voltage Level.  
X = Don't Care.  
Z = HIGH Impedance.  
 $\text{┐}$  = LOW-to-HIGH transition.
2. Output level before indicated steady-state input conditions were established.

## Function Table<sup>[1]</sup>

| Inputs                 |                         |                           |            |   |                  | Outputs  |
|------------------------|-------------------------|---------------------------|------------|---|------------------|----------|
| $\overline{\text{OE}}$ | $\overline{\text{CLR}}$ | $\overline{\text{CLKEN}}$ | CLK        | D | Q                | Function |
| H                      | X                       | X                         | X          | X | Z                | High Z   |
| L                      | L                       | X                         | X          | X | L                | Clear    |
| L                      | H                       | H                         | X          | X | Q <sup>[2]</sup> | Hold     |
| H                      | H                       | L                         | $\text{┐}$ | L | Z                | Load     |
| H                      | H                       | L                         | $\text{┐}$ | H | Z                |          |
| L                      | H                       | L                         | $\text{┐}$ | L | L                |          |
| L                      | H                       | L                         | $\text{┐}$ | H | H                |          |

Power Dissipation . . . . . 1.0W  
Static Discharge Voltage . . . . .  $>2001\text{V}$   
(per MIL-STD-883, Method 3015)

## Operating Range

| Range      | Ambient Temperature                            | V <sub>CC</sub>      |
|------------|--|----------------------|
| Commercial | $-40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$ | $5\text{V} \pm 10\%$ |

3. Operation beyond the limits set forth may impair the useful life of the device. Unless otherwise noted, these limits are over the operating free-air temperature range.
4. Unused inputs must always be connected to an appropriate logic voltage level, preferably either V<sub>CC</sub> or ground.

**Electrical Characteristics** Over the Operating Range

| Parameter        | Description   | Test Conditions  | Min. | Typ. <sup>[5]</sup> | Max. | Unit |
|------------------|---|--|------|---------------------|------|------|
| V <sub>IH</sub>  | Input HIGH Voltage                                      |  | 2.0  |                     |      | V    |
| V <sub>IL</sub>  | Input LOW Voltage                                       |  |      |                     | 0.8  | V    |
| V <sub>H</sub>   | Input Hysteresis <sup>[6]</sup>                         |  |      | 100                 |      | mV   |
| V <sub>IK</sub>  | Input Clamp Diode Voltage                               | V <sub>CC</sub> =Min., I <sub>IN</sub> =−18 mA         |      | −0.7                | −1.2 | V    |
| I <sub>IH</sub>  | Input HIGH Current                                      | V <sub>CC</sub> =Max., V <sub>I</sub> =V <sub>CC</sub> |      |                     | ±1   | μA   |
| I <sub>IL</sub>  | Input LOW Current                                       | V <sub>CC</sub> =Max., V <sub>I</sub> =GND             |      |                     | ±1   | μA   |
| I <sub>OZH</sub> | High Impedance Output Current (Three-State Output pins) | V <sub>CC</sub> =Max., V <sub>OUT</sub> =2.7V          |      |                     | ±1   | μA   |
| I <sub>OZL</sub> | High Impedance Output Current (Three-State Output pins) | V <sub>CC</sub> =Max., V <sub>OUT</sub> =0.5V          |      |                     | ±1   | μA   |
| I <sub>OS</sub>  | Short Circuit Current <sup>[7]</sup>                    | V <sub>CC</sub> =Max., V <sub>OUT</sub> =GND           | −80  | −140                | −200 | mA   |
| I <sub>O</sub>   | Output Drive Current <sup>[7]</sup>                     | V <sub>CC</sub> =Max., V <sub>OUT</sub> =2.5V          | −50  |                     | −180 | mA   |
| I <sub>OFF</sub> | Power-Off Disable                                       | V <sub>CC</sub> =0V, V <sub>OUT</sub> ≤4.5V            |      |                     | 1    | μA   |

**Output Drive Characteristics for CY74FCT16823T**

| Parameter       | Description         | Test Conditions                                | Min. | Typ. <sup>[5]</sup> | Max. | Unit |
|-----------------|---------------------|--|------|---------------------|------|------|
| V <sub>OH</sub> | Output HIGH Voltage | V <sub>CC</sub> =Min., I <sub>OH</sub> =−3 mA  | 2.5  | 3.5                 |      | V    |
|                 |                     | V <sub>CC</sub> =Min., I <sub>OH</sub> =−15 mA | 2.4  | 3.5                 |      | V    |
|                 |                     | V <sub>CC</sub> =Min., I <sub>OH</sub> =−32 mA | 2.0  | 3.0                 |      | V    |
| V <sub>OL</sub> | Output LOW Voltage  | V <sub>CC</sub> =Min., I <sub>OL</sub> =64 mA  |      | 0.2                 | 0.55 | V    |

**Output Drive Characteristics for CY74FCT162823T**

| Parameter        | Description                        | Test Conditions   | Min. | Typ. <sup>[5]</sup> | Max. | Unit |
|------------------|------------------------------------|---|------|---------------------|------|------|
| I <sub>ODL</sub> | Output LOW Voltage <sup>[7]</sup>  | V <sub>CC</sub> =5V, V <sub>IN</sub> =V <sub>IH</sub> or V <sub>IL</sub> , V <sub>OUT</sub> =1.5V | 60   | 115                 | 150  | mA   |
| I <sub>ODH</sub> | Output HIGH Voltage <sup>[7]</sup> | V <sub>CC</sub> =5V, V <sub>IN</sub> =V <sub>IH</sub> or V <sub>IL</sub> , V <sub>OUT</sub> =1.5V | −60  | −115                | −150 | mA   |
| V <sub>OH</sub>  | Output HIGH Voltage                | V <sub>CC</sub> =Min., I <sub>OH</sub> =−24 mA  | 2.4  | 3.3                 |      | V    |
| V <sub>OL</sub>  | Output LOW Voltage                 | V <sub>CC</sub> =Min., I <sub>OL</sub> =24 mA   |      | 0.3                 | 0.55 | V    |

**Capacitance<sup>[8]</sup>** (T<sub>A</sub> = +25°C, f = 1.0 MHz)

| Parameter        | Description        | Test Conditions       | Typ. <sup>[5]</sup> | Max. | Unit |
|------------------|--------------------|-----------------------|---------------------|------|------|
| C <sub>IN</sub>  | Input Capacitance  | V <sub>IN</sub> = 0V  | 4.5                 | 6.0  | pF   |
| C <sub>OUT</sub> | Output Capacitance | V <sub>OUT</sub> = 0V | 5.5                 | 8.0  | pF   |

**Notes:**

5. Typical values are at V<sub>CC</sub>=5.0V, T<sub>A</sub>=+25°C ambient.

6. This input is guaranteed but not tested.

7. Not more than one output should be shorted at a time. Duration of short should not exceed one second. The use of high-speed test apparatus and/or sample and hold techniques are preferable in order to minimize internal chip heating and more accurately reflect

operational values. Otherwise prolonged shorting of a high output may raise the chip temperature well above normal and thereby cause invalid readings in other parametric tests. In any sequence of parameter tests, I<sub>OS</sub> tests should be performed last.

8. This parameter is guaranteed but not tested.

**Power Supply Characteristics**

| Parameter        | Description                                      | Test Conditions <sup>[9]</sup>   |   | Min. | Typ. <sup>[5]</sup> | Max.                 | Unit       |
|------------------|--|--|---|------|---------------------|----------------------|------------|
| I <sub>CC</sub>  | Quiescent Power Supply Current                   | V <sub>CC</sub> =Max.  | V <sub>IN</sub> ≤0.2V<br>V <sub>IN</sub> ≥V <sub>CC</sub> -0.2V | —    | 5                   | 500                  | μA         |
| ΔI <sub>CC</sub> | Quiescent Power Supply Current (TTL inputs HIGH) | V <sub>CC</sub> =Max.  | V <sub>IN</sub> =3.4V <sup>[10]</sup>                           | —    | 0.5                 | 1.5                  | mA         |
| I <sub>CCD</sub> | Dynamic Power Supply Current <sup>[11]</sup>     | V <sub>CC</sub> =Max.,<br>One Input Toggling,<br>50% Duty Cycle,<br>Outputs Open,<br>OE=CLKEN=GND  | V <sub>IN</sub> =V <sub>CC</sub> or<br>V <sub>IN</sub> =GND     | —    | 75                  | 120                  | μA/<br>MHz |
| I <sub>C</sub>   | Total Power Supply Current <sup>[12]</sup>       | V <sub>CC</sub> =Max.,<br>f <sub>0</sub> =10 MHz,<br>50% Duty Cycle,<br>Outputs Open,<br>One Bit Toggling,<br>OE=CLKEN=GND<br>at f <sub>1</sub> =5 MHz         | V <sub>IN</sub> =V <sub>CC</sub> or<br>V <sub>IN</sub> =GND     | —    | 0.8                 | 1.7                  | mA         |
|                  |  |  | V <sub>IN</sub> =3.4V or<br>V <sub>IN</sub> =GND                | —    | 1.3                 | 3.2                  |            |
|                  |  | V <sub>CC</sub> =Max.,<br>at f <sub>1</sub> =2.5 MHz,<br>50% Duty Cycle,<br>Outputs Open,<br>Eighteen Bits Toggling,<br>OE=CLKEN=GND<br>f <sub>0</sub> =10 MHz | V <sub>IN</sub> =V <sub>CC</sub> or<br>V <sub>IN</sub> =GND     | —    | 4.2                 | 7.1 <sup>[13]</sup>  |            |
|                  |  |  | V <sub>IN</sub> =3.4V or<br>V <sub>IN</sub> =GND                | —    | 9.2                 | 22.1 <sup>[13]</sup> |            |

**Notes:**

9. For conditions shown as Max. or Min., use appropriate value specified under Electrical Characteristics for the applicable device type.
10. Per TTL driven input (V<sub>IN</sub>=3.4V); all other inputs at V<sub>CC</sub> or GND.
11. This parameter is not directly testable, but is derived for use in Total Power Supply calculations.
12. I<sub>C</sub> = I<sub>QUIESCENT</sub> + I<sub>INPUTS</sub> + I<sub>DYNAMIC</sub>  
I<sub>C</sub> = I<sub>CC</sub> + ΔI<sub>CC</sub>D<sub>H</sub>N<sub>T</sub> + I<sub>CCD</sub>(f<sub>0</sub>/2 + f<sub>1</sub>N<sub>1</sub>)  
I<sub>CC</sub> = Quiescent Current with CMOS input levels  
ΔI<sub>CC</sub> = Power Supply Current for a TTL HIGH input (V<sub>IN</sub>=3.4V)

- D<sub>H</sub> = Duty Cycle for TTL inputs HIGH  
N<sub>T</sub> = Number of TTL inputs at D<sub>H</sub>  
I<sub>CCD</sub> = Dynamic Current caused by an input transition pair (HLH or LHL)  
f<sub>0</sub> = Clock frequency for registered devices, otherwise zero  
f<sub>1</sub> = Input signal frequency  
N<sub>1</sub> = Number of inputs changing at f<sub>1</sub>  
All currents are in milliamps and all frequencies are in megahertz.
13. Values for these conditions are examples of the I<sub>CC</sub> formula. These limits are guaranteed but not tested.

**Switching Characteristics** Over the Operating Range<sup>[14]</sup>

| Parameter                            | Description                                | Condition <sup>[15]</sup>                                      | 74FCT16823AT<br>74FCT162823AT |      | 74FCT16823BT<br>74FCT162823BT |      | 74FCT16823CT<br>74FCT162823CT |      | Unit | Fig. No. <sup>[16]</sup> |
|--------------------------------------|--|--|-------------------------------|------|-------------------------------|------|-------------------------------|------|------|--------------------------|
|                                      |  |  | Min.                          | Max. | Min.                          | Max. | Min.                          | Max. |      |                          |
| t <sub>PLH</sub><br>t <sub>PHL</sub> | Propagation Delay<br>CLK to Q              | C <sub>L</sub> =50 pF<br>R <sub>L</sub> =500Ω                  | 1.5                           | 10.0 | 1.5                           | 7.5  | 1.5                           | 6.0  | ns   | 1, 5                     |
|                                      |  | C <sub>L</sub> =300 pF <sup>[17]</sup><br>R <sub>L</sub> =500Ω | 1.5                           | 20.0 | 1.5                           | 15.0 | 1.5                           | 12.5 |      |                          |
| t <sub>PHL</sub>                     | Propagation Delay<br>CLR to Q              | C <sub>L</sub> =50 pF<br>R <sub>L</sub> =500Ω                  | 1.5                           | 14.0 | 1.5                           | 9.0  | 1.5                           | 6.1  | ns   | 1, 5                     |
| t <sub>PZH</sub><br>t <sub>PZL</sub> | Output Enable Time<br>OE to Q              | C <sub>L</sub> =50 pF<br>R <sub>L</sub> =500Ω                  | 1.5                           | 12.0 | 1.5                           | 8.0  | 1.5                           | 5.5  | ns   | 1, 7, 8                  |
|                                      |  | C <sub>L</sub> =300 pF <sup>[17]</sup><br>R <sub>L</sub> =500Ω | 1.5                           | 23.0 | 1.5                           | 15.0 | 1.5                           | 12.5 |      |                          |
| t <sub>PHZ</sub><br>t <sub>PLZ</sub> | Output Disable Time<br>OE to Q             | C <sub>L</sub> =5 pF <sup>[17]</sup><br>R <sub>L</sub> =500Ω   | 1.5                           | 7.0  | 1.5                           | 6.5  | 1.5                           | 5.2  | ns   | 1, 7, 8                  |
|                                      |  | C <sub>L</sub> =50 pF<br>R <sub>L</sub> =500Ω                  | 1.5                           | 8.0  | 1.5                           | 7.5  | 1.5                           | 6.5  |      |                          |
| t <sub>SU</sub>                      | Set-Up Time<br>HIGH or LOW<br>D to CLK     | C <sub>L</sub> =50 pF<br>R <sub>L</sub> =500Ω                  | 3.0                           | —    | 3.0                           | —    | 2.0                           | —    | ns   | 4                        |
| t <sub>H</sub>                       | Hold Time<br>HIGH or LOW<br>D to CLK       |  | 1.5                           | —    | 1.5                           | —    | 1.5                           | —    | ns   | 4                        |
| t <sub>SU</sub>                      | Set-Up Time<br>HIGH or LOW<br>CLKEN to CLK |  | 3.0                           | —    | 3.0                           | —    | 3.0                           | —    | ns   | 9                        |
| t <sub>H</sub>                       | Hold Time HIGH or<br>LOW<br>CLKEN to CLK   |  | 0                             | —    | 0                             | —    | 0                             | —    | ns   | 9                        |
| t <sub>W</sub>                       | CLK Pulse Width<br>HIGH or LOW             |  | 6.0                           | —    | 6.0                           | —    | 3.3                           | —    | ns   | 5                        |
| t <sub>W</sub>                       | CLR Pulse Width LOW                        |  | 6.0                           | —    | 6.0                           | —    | 3.3                           | —    | ns   | 5                        |
| t <sub>REM</sub>                     | Recovery Time<br>CLR to CLK                |  | 6.0                           | —    | 6.0                           | —    | 6.0                           | —    | ns   | 6                        |
| t <sub>SK(O)</sub>                   | Output Skew <sup>[18]</sup>                |  | —                             | 0.5  | —                             | 0.5  | —                             | 0.5  | ns   | —                        |

**Notes:**

14. Minimum limits are guaranteed but not tested on Propagation Delays.  
15. See test circuit and waveforms.  
16. See “Parameter Measurement Information” in the General Information section.

17. These limits are guaranteed but not tested.  
18. Skew between any two outputs of the same package switching in the same direction. This parameter is guaranteed by design.



**Ordering Information CY74FCT16823**

| Speed (ns) | Ordering Code     | Package Name | Package Type            | Operating Range |
|------------|-------------------|--------------|-------------------------|-----------------|
| 6.0        | CY74FCT16823CTPAC | Z56          | 56-Lead (240-Mil) TSSOP | Commercial      |
|            | CY74FCT16823CTPVC | O56          | 56-Lead (300-Mil) SSOP  |                 |
| 7.5        | CY74FCT16823BTPAC | Z56          | 56-Lead (240-Mil) TSSOP | Commercial      |
|            | CY74FCT16823BTPVC | O56          | 56-Lead (300-Mil) SSOP  |                 |
| 10.0       | CY74FCT16823ATPAC | Z56          | 56-Lead (240-Mil) TSSOP | Commercial      |
|            | CY74FCT16823ATPVC | O56          | 56-Lead (300-Mil) SSOP  |                 |

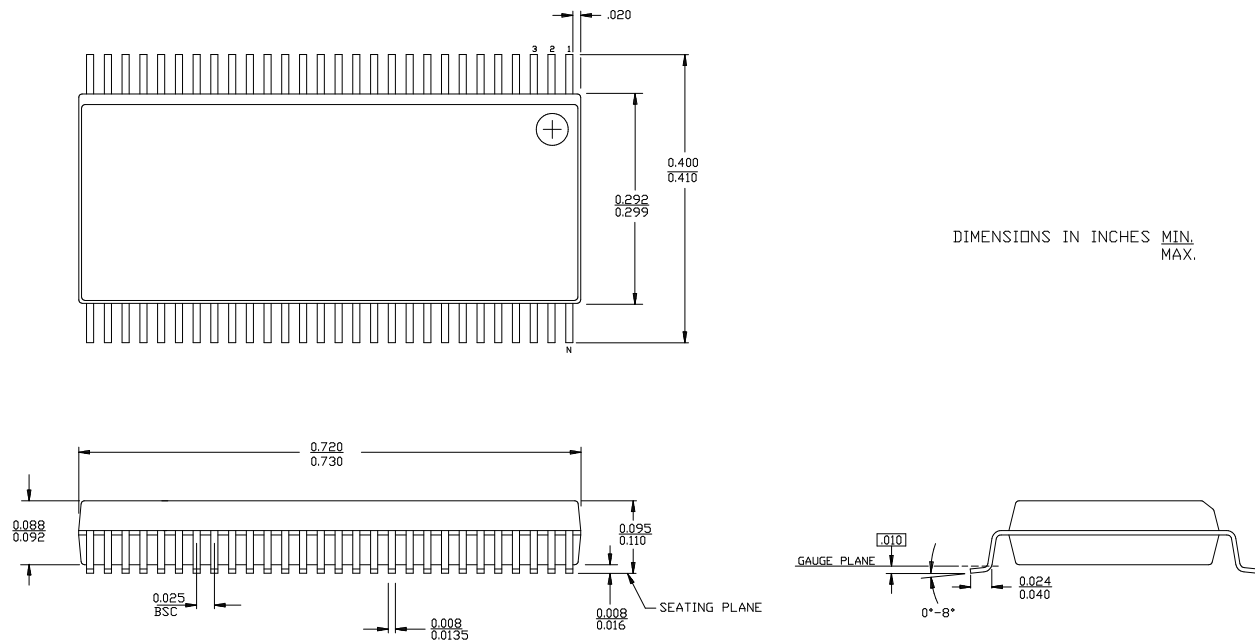
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| Speed (ns) | Ordering Code      | Package Name | Package Type            | Operating Range |
|------------|--------------------|--------------|-------------------------|-----------------|
| 6.0        | CY74FCT162823CTPAC | Z56          | 56-Lead (240-Mil) TSSOP | Commercial      |
|            | CY74FCT162823CTPVC | O56          | 56-Lead (300-Mil) SSOP  |                 |
| 7.5        | CY74FCT162823ATPAC | Z56          | 56-Lead (240-Mil) TSSOP | Commercial      |
|            | CY74FCT162823ATPVC | O56          | 56-Lead (300-Mil) SSOP  |                 |
| 10.0       | CY74FCT162823TPAC  | Z56          | 56-Lead (240-Mil) TSSOP | Commercial      |
|            | CY74FCT162823TPVC  | O56          | 56-Lead (300-Mil) SSOP  |                 |

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## Package Diagrams

### 56-Lead Shrunk Small Outline Package O56



### 56-Lead Thin Shrunk Small Outline Package Z56

